


<b>Search Notes</b>  	<b>Application/Control No.</b>  10668846	<b>Applicant(s)/Patent Under Reexamination</b>  SMITH ET AL.
	<b>Examiner</b>  Lockard, Jon M	<b>Art Unit</b>  1647

SEARCHED			
Class	Subclass	Date	Examiner
NONE		2/12/07	JML

SEARCH NOTES		
Search Notes	Date	Examiner
STIC Search of SEQ ID NOs:1 and 2: See sequence search results in SCORE.	1/22/07	JML
East Search (USPAT, US-PGPUB, EPO, DERWENT): Inventor Name and Text Search. See Attached Search History.	2/12/07	JML
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS): See Attached Search History.	2/12/07	JML
PALM: Inventor Search.	2/12/07	JML
UPDATED (EAST, STN, and PALM): See Attached.	8/28/07	JML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner